MT9410

N-Channel PowerTrench[®]MOSFET 30V, 5.6A, 25m Ω

General Description

This N-Channel MOSFET is produced using Mos-tech Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching perfomance.

These devices are well suited for low voltage and battery powered applications where low in line power loss and fast switching are required.

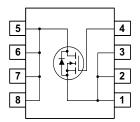
Features

- R $_{\text{DS(on)}}$ = 25m Ω , V $_{\text{GS}}$ = 10V, I $_{\text{D}}$ = 5.6A
- $R_{DS(on)}$ = 36m Ω , V_{GS} = 4.5V, I_D = 5.6A
- · Low gate charge(9.5nC typical)
- High performance trench technology for extremely low RDS(ON)
- High power and current handling capability

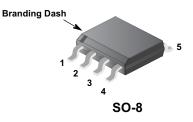


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Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT



Absolute Maximum Ratings(T_A = 25°C unless otherwise noted)

| Symbol | | Parameter | | Ratings | Units | |
|-----------------------------------|--|--|-----------------|-------------|------------|--|
| VDSS | Drain-Source Voltage | | | 30 | V | |
| V _{GSS} | Gate-Source Voltage | | | ±20 | V | |
| Ь | Drain Curre | nt – Continuous | (Note 1a) | 5.6 | А | |
| | | – Pulsed | | 28 | | |
| PD | Power Dissi | pation for Single Operation | ation (Note 1a) | 2.5 | W | |
| | | | (Note 1b) | 1.2 | | |
| | | | (Note 1c) | 1.0 | | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | | –55 to +175 | °C | |
| Therma | I Charact | eristics | | | | |
| R _{0JA} | | Thermal Resistance, Junction-to-Ambient (Note 1a) 50 | | °C/W | | |
| R _{ejc} | Thermal Re | nermal Resistance, Junction-to-Case (Note 1) | | 25 | | |
| Packag | e Marking | g and Ordering | g Information | | | |
| Device Marking | | Device | Reel Size | Tape width | Quantity | |
| MT9410 | | MT9410 | 13" | 12mm | 2500 units | |

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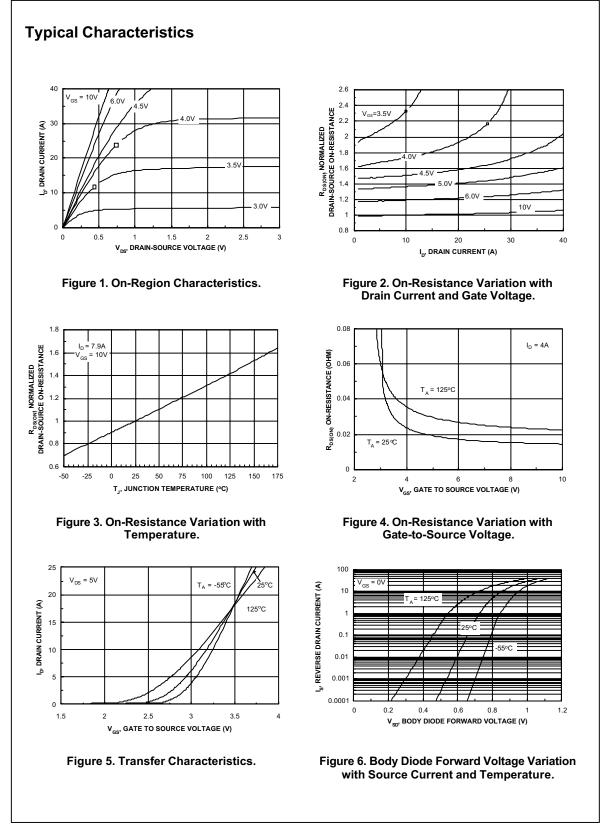
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| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|--|--|--------------|----------|------------------------|-------|
| Off Char | acteristics | 1 | | | | |
| BV _{DSS} | Drain–Source Breakdown Voltage | $V_{GS} = 0 V$, $I_D = 250 \mu A$ | 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $l_{\rm b}$ = 250 µA, Referenced to 25°C | | 21 | | mV/ºC |
| DSS | Zero Gate Voltage Drain Current | $V_{DS} = 24 V$, $V_{GS} = 0 V$ | | | 1 | μA |
| GSSF | Gate–Body Leakage, Forward | $V_{GS} = 25 V$, $V_{DS} = 0 V$ | | | 100 | nA |
| | Gate–Body Leakage, Reverse | $V_{GS} = -25 V$, $V_{DS} = 0 V$ | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$ | 1 | 1.8 | 2 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | I_D = 250 µA, Referenced to 25°C | | -6 | | mV/ºC |
| R _{DS(on)} | Static Drain–Source | | 25 | 38 | mΩ | |
| | On–Resistance | $V_{GS} = 4.5 V$, $I_D = 5.6 A$ $V_{GS} = 10 V$, $I_D = 5.6 A$, $T_J = 125^{\circ}C$ | | 36 28 | 50 45 | |
| I _{D(on)} | On–State Drain Current | $V_{GS} = 10 V$, $V_{DS} = 5 V$ | 20 | | | А |
| g fs | Forward Transconductance | V _{DS} = 10 V, I _D = 5.6 A | | 24 | | S |
| Dynamic | Characteristics | | | | | |
| Ciss | Input Capacitance | $V_{DS} = 15 V$, $V_{GS} = 0 V$, | | 927 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 241 | | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 | | 97 | | pF |
| Switchin | g Characteristics (Note 2) | • | | | | |
| t _{d(on)} | Turn–On Delay Time | $V_{DD} = 15 V$, $I_D = 1 A$, | | 7.4 | 15 | ns |
| tr | Turn–On Rise Time | $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | | 7.5 | 15 | ns |
| t _{d(off)} | Turn–Off Delay Time | 1 | | 25 | 40 | ns |
| t _f | Turn–Off Fall Time | 1 | | 5 | 10 | ns |
| Qg | Total Gate Charge | al Gate Charge $V_{DS} = 15 V$, $I_D = 5.6 A$, | | 9.5 | 13 | nC |
| Q _{gs} | Gate–Source Charge | $V_{GS} = 5 V$ | | 3.3 | | nC |
| Q _{gd} | Gate–Drain Charge | | | 3.1 | | nC |
| Drain-So | ource Diode Characteristics | and Maximum Ratings | • | | | |
| ls | Maximum Continuous Drain–Source | ¥ | | | 2.1 | Α |
| V _{SD} | Drain–Source Diode Forward Voltage | $V_{GS} = 0 V, I_S = 2.1 A$ (Note 2) | | 0.7 | 1.2 | V |
| t _{rr} | Diode Reverse Recovery Time | I _F = 5.6 A, | | 22 | | nS |
| Qrr | Diode Reverse Recovery Charge | d _{iF} /d _t = 100 A/μs | | 20 | | nC |
| otes : R _{eJA} is the sum | of the junction-to-case and case-to-ambient thermal r R _{0JC} is guaranteed by design while R _{0CA} is determined | esistance where the case thermal reference is define | ed as the so | | g surface o | |
| 0,9 | | b) 105°C/W when mounted on a .04 ir? | MA NR | on a | °C/W when a minimum | |

Scale 1 : 1 on letter size paper

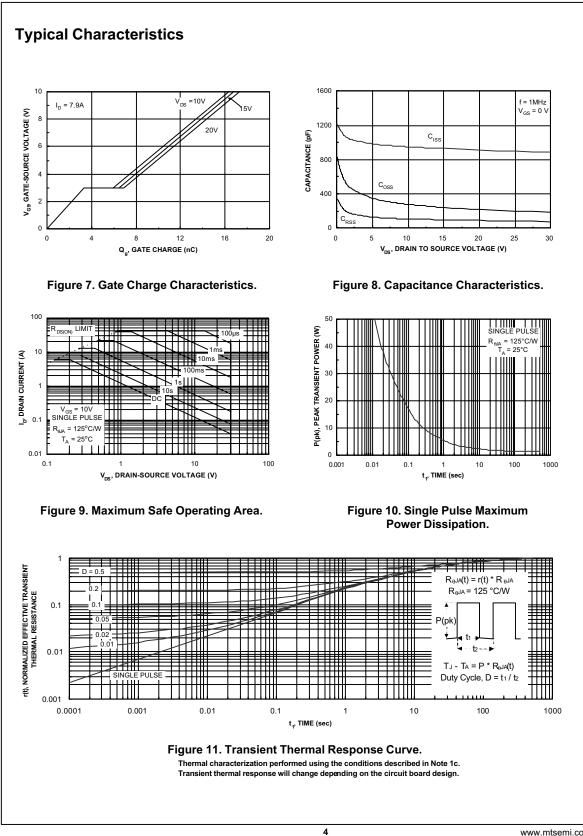
a φ c α 2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

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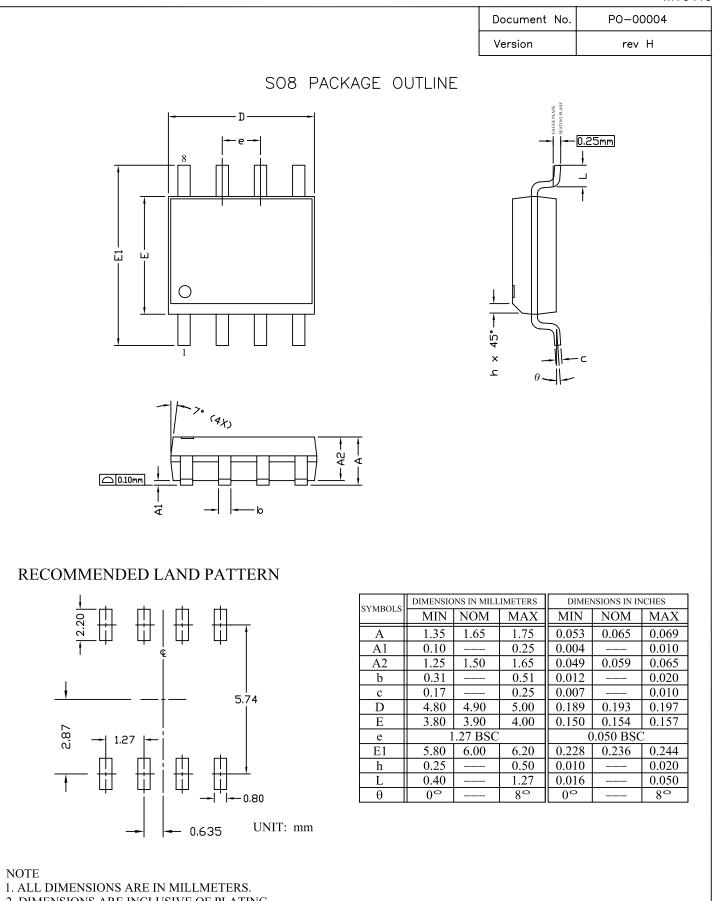
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- 2. DIMENSIONS ARE INCLUSIVE OF PLATING.
- 3. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
- MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 4. DIMENSION L IS MEASURED IN GAUGE PLANE.
- 5. CONTROLLING DIMENSION IS MILLIMETER.
- CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

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